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Revision: -

LITE-ON DCC

RELEASE

BNS-OD-FC001/A4



Through Hole Lamp

LTL-42MDNHKPR

Rev	<u>Description</u>	<u>By</u>	<u>Date</u>
P001	Preliminary Specification	Javy	03/20/2014
	Above data for PD and Customer tracki	ng only	
-	NPPR Received and Upload on OPNC	Chalerm Y	05/28/2014



1. Description

CBI (Circuit Board Indicator) is a black plastic right angle Holder (Housing) which mates with Lite-On LED lamps. Lite-On CBI is available in a wide variety of packages, including top-view (Spacer) or right angle and horizontal or vertical arrays which is stackable and easy to assembly.

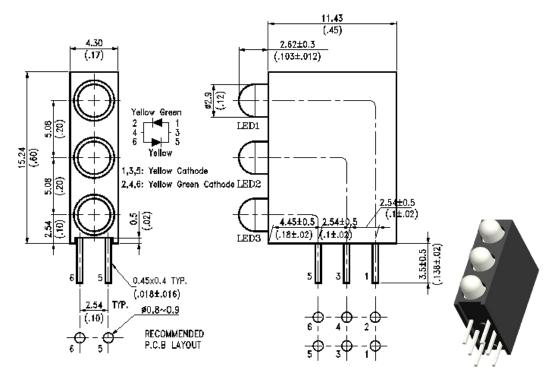
1. 1. Features

- Designed for ease in circuit board assembly
- Black case enhance contrast ratio
- Solid state light source
- Low power consumption & High efficiency
- Lead free product & RoHS Compliant
- T-1 lamp: Source bi-color are GaP yellow 588nm/ GaP yellow green 569nm chips.

1.2. Applications

- Communication
- Computer
- Consumer
- Home appliance

2. Outline Dimensions



Notes:

- 1. All dimensions are in millimeters (inches).
- 2. Tolerance is ±0.25mm (.010") unless otherwise noted.
- 3. The Holder (Housing) material is plastic black.
- 4. LED1~3 lamps are yellow / yellow green bi-color with white diffused Lens.
- 5. Specifications are subject to change without notice.



3. Absolute Maximum Ratings at TA=25°C

Parameter	Yellow	Yellow Green	Unit		
Power Dissipation	60	100	mW		
Peak Forward Current					
(Duty Cycle≦1/10, Pulse Width≦10ms)	80	120	mA		
DC Forward Current	20	30	mA		
Operating Temperature Range	-40°C to + 85°C				
Storage Temperature Range	-40°C to + 100°C				
Lead Soldering Temperature					
[2.0mm (.079") From Body]	260°C for 5 Seconds Max.				

4. Electrical / Optical Characteristics at TA=25°C

Parameter	Symbol	Color	Min.	Тур.	Max.	Unit	Test Condition
Luminaua Intanaitu	IV	Yellow	2.5	8.7	100	mad	IF=20mA
Luminous Intensity	IV	Yellow Green	3.7	12.6	100	mcd	Note 1,4
Viewing Angle	201/2	Yellow		80		doa	Note 2 (Fig.6)
Viewing Angle	201/2	Yellow Green		80		deg	
Dook Emission Wayslandth	λP	Yellow		585			Measurement
Peak Emission Wavelength	۸۲	Yellow Green		565		nm	@Peak (Fig.1)
Deminent Weyelen ath	λd	Yellow	580	588	600	nm	IF 20m A Note 2
Dominant Wavelength	λά	Yellow Green	564	569	578	nm	IF=20mA, Note 3
Constrail in a Half \\/idth	Δλ	Yellow		35			
Spectral Line Half-Width		Yellow Green		30		nm	
Forward Valtage	VF	Yellow		2.1	2.6	V	IF=20mA
Forward Voltage	VF	Yellow Green		2.1	2.6	V	IF=20MA
Daylorga Current	10	Yellow			400		VD EV Note C
Reverse Current	IR	Yellow Green			100	μA	VR=5V, Note 6

NOTE:

- 1. Luminous intensity is measured with a light sensor and filter combination that approximates the CIE eye-response curve.
- 2. θ 1/2 is the off-axis angle at which the luminous intensity is half the axial luminous intensity.
- 3. The dominant wavelength, λd is derived from the CIE chromaticity diagram and represents the single wavelength which defines the color of the device.
- 4. Iv guarantee must be included with ±30% testing tolerance.
- 5. Reverse current is controlled by dice source.
- 6. Reverse voltage (VR) condition is applied for IR test only. The device is not designed for reverse operation.



5. Typical Electrical / Optical Characteristics Curves

(25°C Ambient Temperature Unless Otherwise Noted)

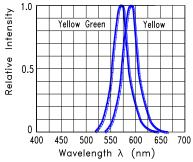


Fig.1 Relative Intensity VS. Wavelength

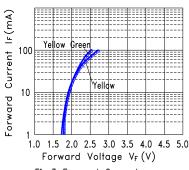


Fig.3 Forward Current vs.
Forward Voltage

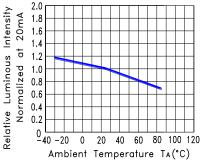


Fig.5 Relative Luminous Intensity

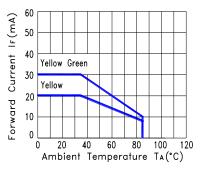


Fig.2 Forward Current Derating Curve

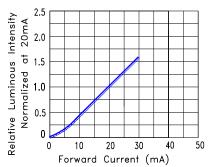


Fig.4 Relative Luminous Intensity vs. Forward Current

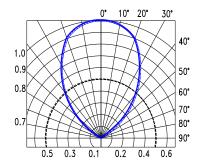
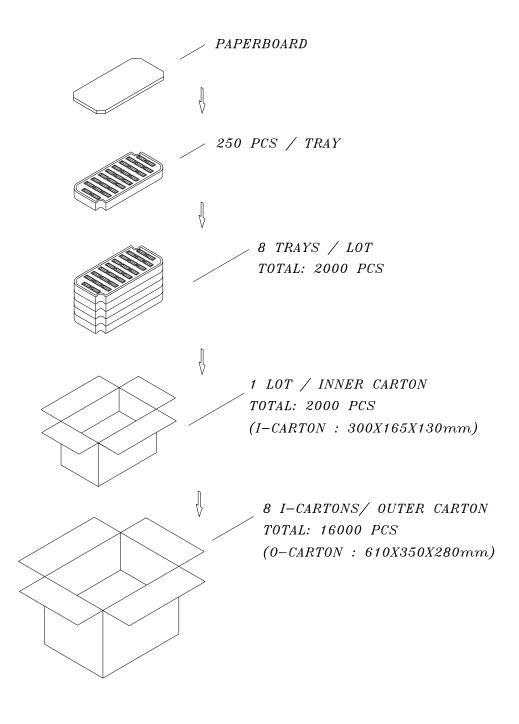


Fig.6 Spatial Distribution



6. Packing Specification





7. Bin Table Specification

	Luminous Intensity (Yellow Green)			Luminous Intensity (Yellow)				
Die	Dominant Wavelength (Yellow Green) IF=20mA			Dominant Wavelength (Yellow) IF=20mA				
Bin Grade	ly Vallow G		Hue Yellow	Green (nm)	lv Yellov		Hue Yellow (nm)	
Orace	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.
	IVIIII.	IVIAA.	IVIII.	Maxi	IVIIII.	Maxi	IVIIII.	Maxi
1	7.5	100	564.0	578.0	4.5	100	580	589
2	7.5	100	564.0	578.0	4.5	100	589	600
3	7.5	100	564.0	578.0	2.5	4.5	580	589
4	7.5	100	564.0	578.0	2.5	4.5	589	600
5	4.5	7.5	564.0	578.0	4.5	100	580	589
6	4.5	7.5	564.0	578.0	4.5	100	589	600
7	4.5	7.5	564.0	578.0	2.5	4.5	580	589
8	4.5	7.5	564.0	578.0	2.5	4.5	589	600
9	3.7	4.5	564.0	578.0	4.5	100	580	589
10	3.7	4.5	564.0	578.0	4.5	100	589	600
11	3.7	4.5	564.0	578.0	2.5	4.5	580	589
12	3.7	4.5	564.0	578.0	2.5	4.5	589	600

Note: Tolerance of each Iv bin limit is $\pm 30\%$

Tolerance of each Hue bin limit is ±1nm



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8. CAUTIONS

8.1. Application

This LED lamp is good for application of indoor and outdoor sign, also ordinary electronic equipment.

8.2. Storage

The storage ambient for the LEDs should not exceed 30°C temperature or 70% relative humidity. It is recommended that LEDs out of their original packaging are used within three months. For extended storage out of their original packaging, it is recommended that the LEDs be stored in a sealed container with appropriate desiccant or in desiccators with nitrogen ambient.

8.3. Cleaning

Use alcohol-based cleaning solvents such as isopropyl alcohol to clean the LEDs if necessary.

8.4. Lead Forming & Assembly

During lead forming, the leads should be bent at a point at least 3mm from the base of LED lens. Do not use the base of the lead frame as a fulcrum during forming. Lead forming must be done before soldering, at normal temperature. During assembly on PCB, use minimum clinch force possible to avoid excessive mechanical stress.

8.5. Soldering

When soldering, leave a minimum of 2mm clearance from the base of the lens/Holder to the soldering point. Dipping the lens/Holder into the solder must be avoided. Do not apply any external stress to the lead frame during soldering while the LED is at high temperature.

Recommended soldering conditions:

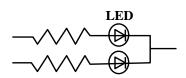
	Soldering iron	Wave soldering		
Temperature Soldering time	350°C Max. 3 seconds Max. (one time only)	Pre-heat Pre-heat time Solder wave	120°C Max. 100 seconds Max. 260°C Max.	
Position	No closer than 2mm from the base of the epoxy bulb	Soldering time Dipping Position	5 seconds Max. No lower than 2mm from the base of the epoxy bulb	

Note: Excessive soldering temperature and/or time might result in deformation of the LED lens or catastrophic failure of the LED. IR reflow is not suitable process for through-hole type LED lamp product. Max temperature of wave soldering is not means that Holder's HDT/Melting temperature.

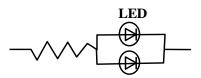
8.6. Drive Method

An LED is a current-operated device. In order to ensure intensity uniformity on multiple LEDs connected in parallel in an application, it is recommended that a current limiting resistor be incorporated in the drive circuit, in series with each LED as shown in Circuit A below.

Circuit model (A)



Circuit model (B)



- (A) Recommended circuit
- (B) The brightness of each LED might appear different due to the differences in the I-V characteristics of those LEDs.



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8.7. ESD (Electrostatic Discharge)

Static Electricity or power surge will damage the LED.

Suggestions to prevent ESD damage:

- Use a conductive wrist band or anti- electrostatic glove when handling these LEDs
- All devices, equipment, and machinery must be properly grounded
- Work tables, storage racks, etc. should be properly grounded
- Use ion blower to neutralize the static charge which might have built up on surface of the LEDs plastic lens as a result of friction between LEDs during storage and handing

Suggested checking list:

Training and Certification

- 8.7.1.1. Everyone working in a static-safe area is ESD-certified?
- 8.7.1.2. Training records kept and re-certification dates monitored?

Static-Safe Workstation & Work Areas

- 8.7.2.1. Static-safe workstation or work-areas have ESD signs?
- 8.7.2.2. All surfaces and objects at all static-safe workstation and within 1 ft measure less than 100V?
- 8.7.2.3. All ionizer activated, positioned towards the units?
- 8.7.2.4. Each work surface mats grounding is good?

Personnel Grounding

- 8.7.3.1. Every person (including visitors) handling ESD sensitive (ESDS) items wear wrist strap, heel strap or conductive shoes with conductive flooring?
- 8.7.3.1. If conductive footwear used, conductive flooring also present where operator stand or walk?
- 8.7.3.2. Garments, hairs or anything closer than 1 ft to ESD items measure less than 100V*?
- 8.7.3.3. Every wrist strap or heel strap/conductive shoes checked daily and result recorded for all DLs?
- 8.7.3.4. All wrist strap or heel strap checkers calibration up to date?

Note: *50V for Blue LED.

Device Handling

- 8.7.4.1. Every ESDS items identified by EIA-471 labels on item or packaging?
- 8.7.4.2. All ESDS items completely inside properly closed static-shielding containers when not at static-safe workstation?
- 8.7.4.3. No static charge generators (e.g. plastics) inside shielding containers with ESDS items?
- 8.7.4.4. All flexible conductive and dissipative package materials inspected before reuse or recycle?

Others

- 8.7.5.1. Audit result reported to entity ESD control coordinator?
- 8.7.5.2. Corrective action from previous audits completed?
- 8.7.5.3. Are audit records complete and on file?



9. Reliability Test

Classification	Test Item	Test Condition	Sample Size	Reference Standard
	Operation Life	Ta = Under room temperature IF = per datasheet maximum drive current Test Time= 1000hrs	22 PCS (CL=90%; LTPD=10%)	MIL-STD-750D:1026 (1995) MIL-STD-883G:1005 (2006)
Endurance	High Temperature High Humidity storage	Ta = 60°C RH = 90% Test Time= 240hrs	22 PCS (CL=90%; LTPD=10%)	MIL-STD-202G:103B (2002) JEITA ED-4701:100 103 (2001)
Test	High Temperature Storage	Ta= 105 ± 5°C Test Time= 1000hrs	22 PCS (CL=90%; LTPD=10%)	MIL-STD-750D:1031 (1995) MIL-STD-883G:1008 (2006) JEITA ED-4701:200 201 (2001)
	Low Temperature Storage	Ta= -55 ± 5°C Test Time= 1000hrs	22 PCS (CL=90%; LTPD=10%)	JEITA ED-4701:200 202 (2001)
	Temperature Cycling	100°C ~ 25°C ~ -40°C ~ 25°C 30mins 5mins 30mins 5mins 30 Cycles	22 PCS (CL=90%; LTPD=10%)	MIL-STD-750D:1051 (1995) MIL-STD-883G:1010 (2006) JEITA ED-4701:100 105 (2001) JESD22-A104C (2005)
	Thermal Shock	100 ± 5°C ~ -30°C ± 5°C 15mins 15mins 30 Cycles (<20 secs transfer)	22 PCS (CL=90%; LTPD=10%)	MIL-STD-750D:1056 (1995) MIL-STD-883G:1011 (2006) MIL-STD-202G:107G (2002) JESD22-A106B (2004)
Environmental Test	Solder Resistance	T.sol = 260 ± 5°C Dwell Time= 10±1 seconds 3mm from the base of the epoxy bulb	11 PCS (CL=90%; LTPD=18.9%)	MIL-STD-750D:2031(1995) JEITA ED-4701: 300 302 (2001)
	Solderability	T. sol = $245 \pm 5^{\circ}$ C Dwell Time= 5 ± 0.5 seconds (Lead Free Solder, Coverage $\geq 95\%$ of the dipped surface)	11 PCS (CL=90%; LTPD=18.9%)	MIL-STD-750D:2026 (1995) MIL-STD-883G:2003 (2006) MIL-STD-202G:208H (2002) IPC/EIA J-STD-002 (2004)
	Soldering Iron	T. sol = $350 \pm 5^{\circ}$ C Dwell Time= 3.5 ± 0.5 seconds	11 PCS (CL=90%; LTPD=18.9%)	MIL-STD-202G:208H (2002) JEITA ED-4701:300 302 (2001)

10. Others

The appearance and specifications of the product may be modified for improvement, without prior notice.